FAIRCHILD SEMICONDUCTOR®

May 2006

UniFET™

FDP79N15 / FDPF79N15
150V N-Channel MOSFET

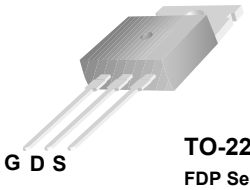
Features

- 79A, 150V, $R_{DS(on)}$ = 0.03Ω @V_{GS} = 10 V
- Low gate charge (typical 56 nC)
- Low Crss (typical 96pF)
- Fast switching
- Improved dv/dt capability

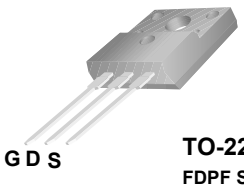
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

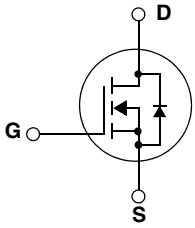
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



TO-220
FDP Series



TO-220F
FDPF Series



Absolute Maximum Ratings

Symbol	Parameter		FDP79N15	FDPF79N15	Unit
V_{DSS}	Drain-Source Voltage		150		V
I_D	Drain Current	- Continuous (T_C = 25°C) - Continuous (T_C = 100°C)	79 50	79* 50*	A A
I_{DM}	Drain Current	- Pulsed (Note 1)	316	316*	A
V_{GSS}	Gate-Source voltage		± 30		V
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	1669		mJ
I_{AR}	Avalanche Current	(Note 1)	79		A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	46.3		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5		V/ns
P_D	Power Dissipation	(T_C = 25°C) - Derate above 25°C	463 3.7	31 0.25	W W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150		°C
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		°C

*Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP79N15	FDPF79N15	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.27	--	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP79N15	FDP79N15	TO-220	-	-	50
FDPF79N15	FDPF79N15	TO-220F	-	-	50

Electrical Characteristics T_C = 25°C unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V, I_D = 250μA, T_J = 25°C	150	--	--	V
ΔBV_{DSS} / ΔT_J	Breakdown Voltage Temperature Coefficient	I_D = 250μA, Referenced to 25°C	--	0.15	--	V/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 150V, V_{GS} = 0V V_{DS} = 120V, T_C = 125°C	-- --	-- --	1 10	μA μA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30V, V_{DS} = 0V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30V, V_{DS} = 0V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250μA	3.0	--	5.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10V, I_D = 39.5A	--	0.025	0.03	Ω
g_{FS}	Forward Transconductance	V_{DS} = 40V, I_D = 39.5A (Note 4)	--	46	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz	--	2620	3410	pF
C_{oss}	Output Capacitance		--	730	950	pF
C_{rss}	Reverse Transfer Capacitance		--	96	140	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 75V, I_D = 79A, R_G = 25Ω	--	50	112	ns
t_r	Turn-On Rise Time		--	200	410	ns
$t_{d(off)}$	Turn-Off Delay Time		--	55	120	ns
t_f	Turn-Off Fall Time	(Note 4, 5)	--	38	85	ns
Q_g	Total Gate Charge	V_{DS} = 120V, I_D = 79A, V_{GS} = 10V	--	56	73	nC
Q_{gs}	Gate-Source Charge		--	18	--	nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)	--	21	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	79	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	316	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0V, I_S = 79A	--	--	1.4	V
t_{rr}	Reverse Recovery Time	V_{GS} = 0V, I_S = 79A, dI_F/dt =100A/μs (Note 4)	--	136	--	ns
Q_{rr}	Reverse Recovery Charge		--	2.1	--	μC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L = 0.357mH, I_{AS} = 79A, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C
3. I_{SD} ≤ 79A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

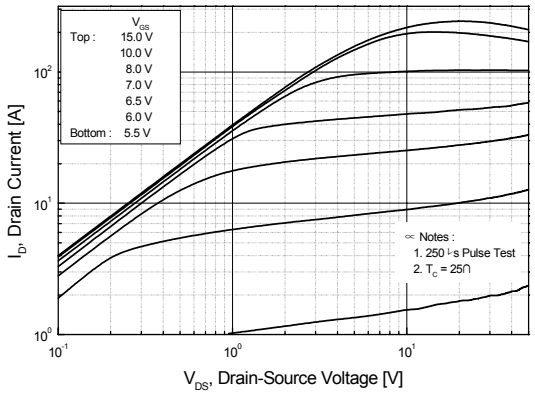


Figure 2. Transfer Characteristics

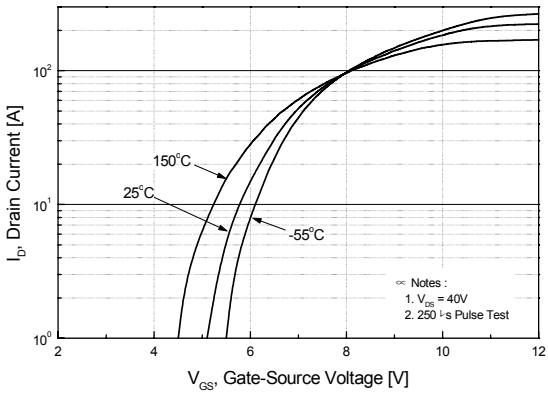


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

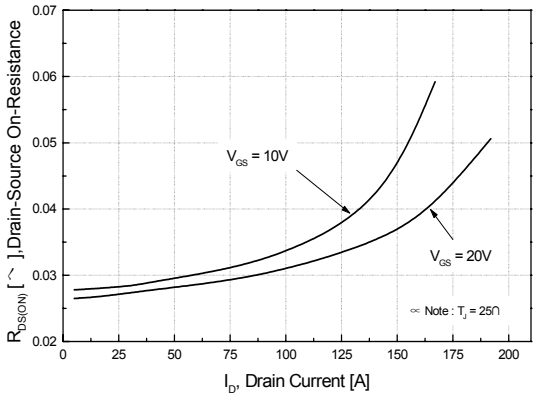


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

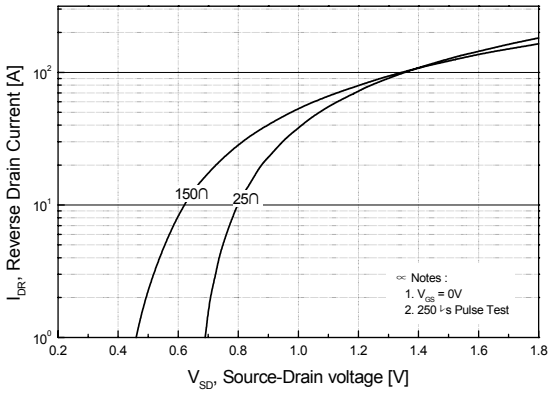


Figure 5. Capacitance Characteristics

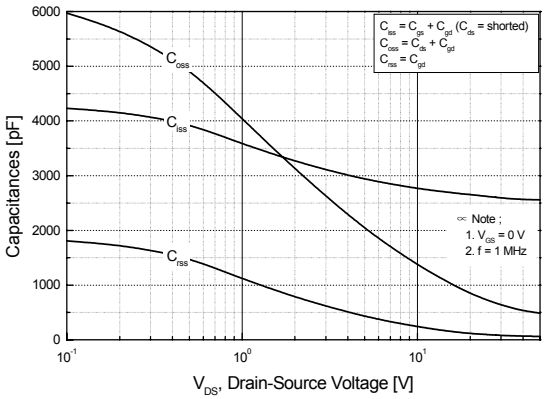
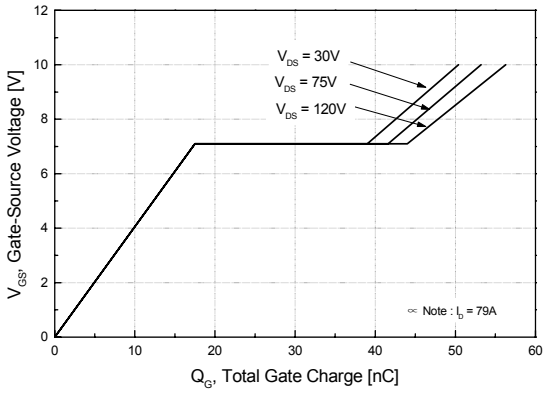


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

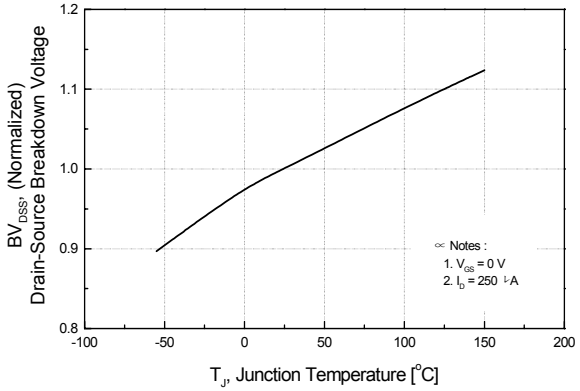


Figure 8. On-Resistance Variation vs. Temperature

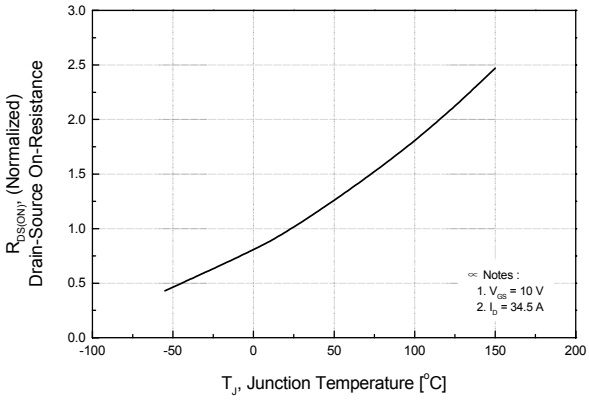


Figure 9-1. Maximum Safe Operating Area for FDP79N15

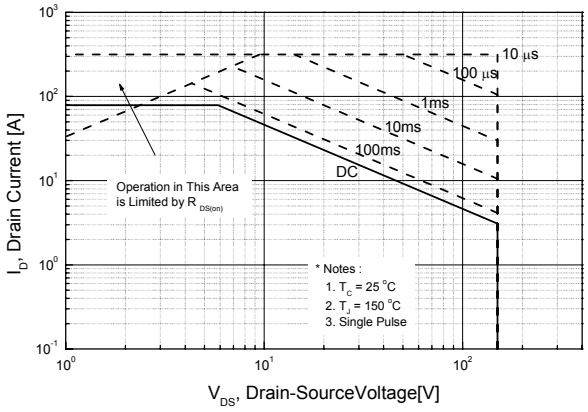


Figure 9-2. Maximum Safe Operating Area for FDPF79N15

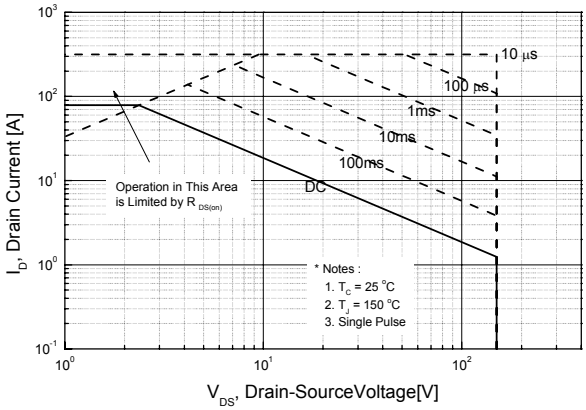
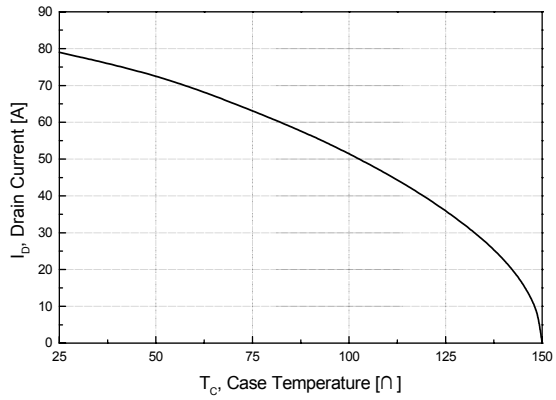


Figure 10. Maximum Drain Current vs. Case Temperature



Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve for FDP79N15

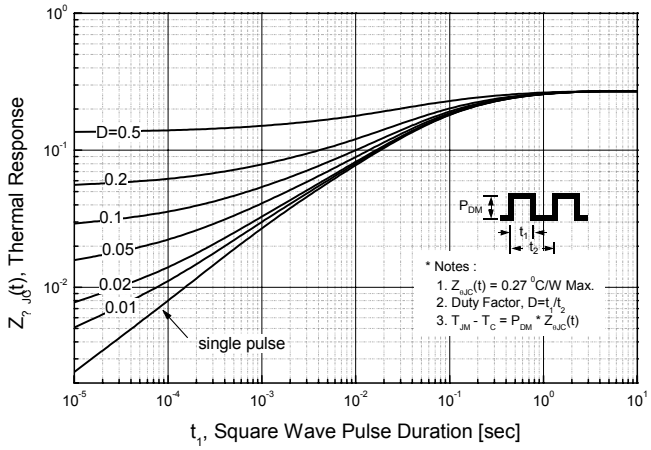
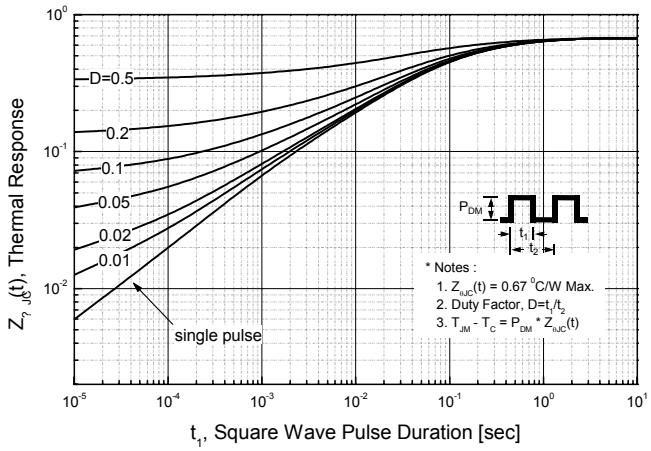
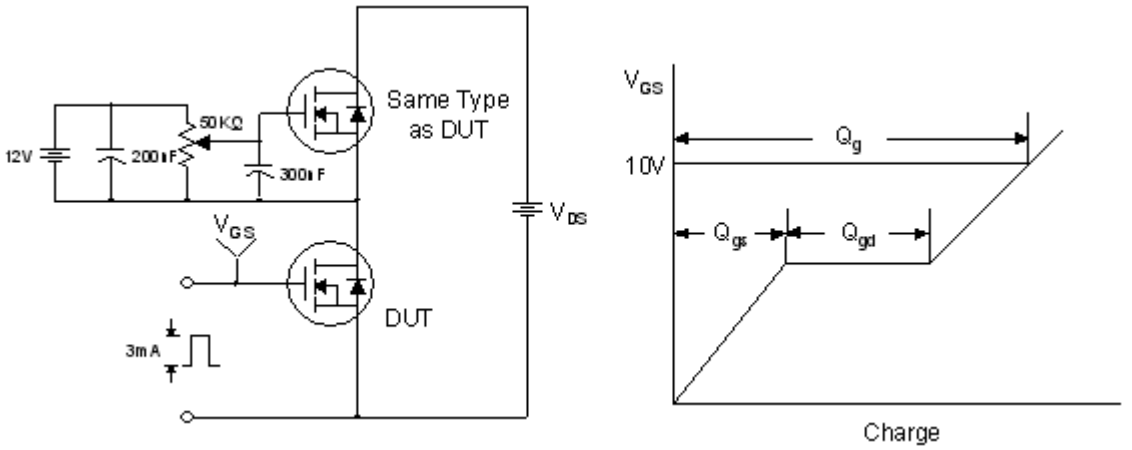


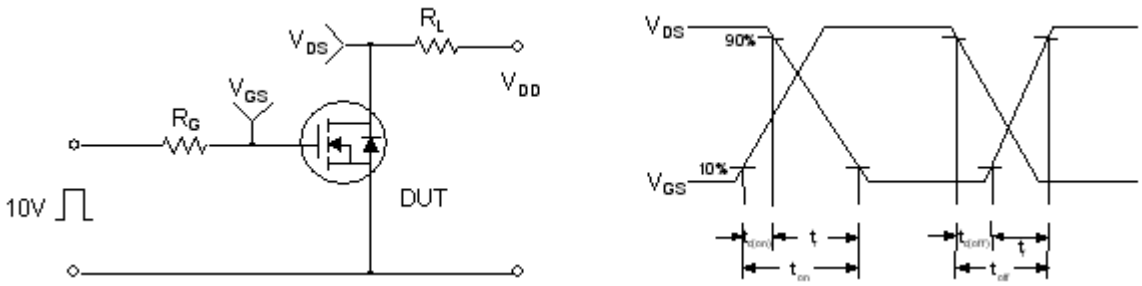
Figure 11-2. Transient Thermal Response Curve for FDPF79N15



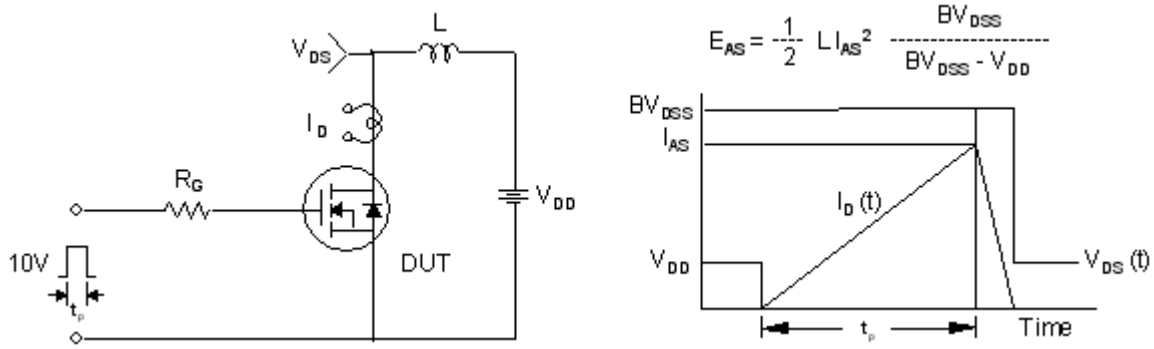
Gate Charge Test Circuit & Waveform



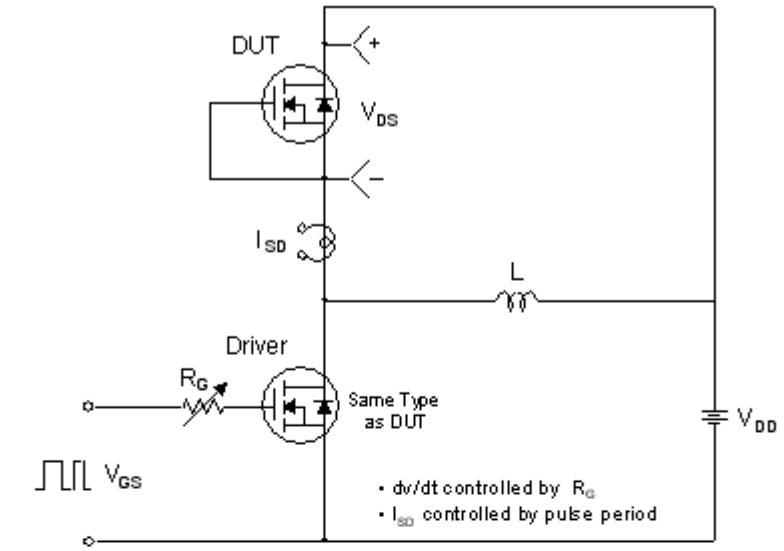
Resistive Switching Test Circuit & Waveforms

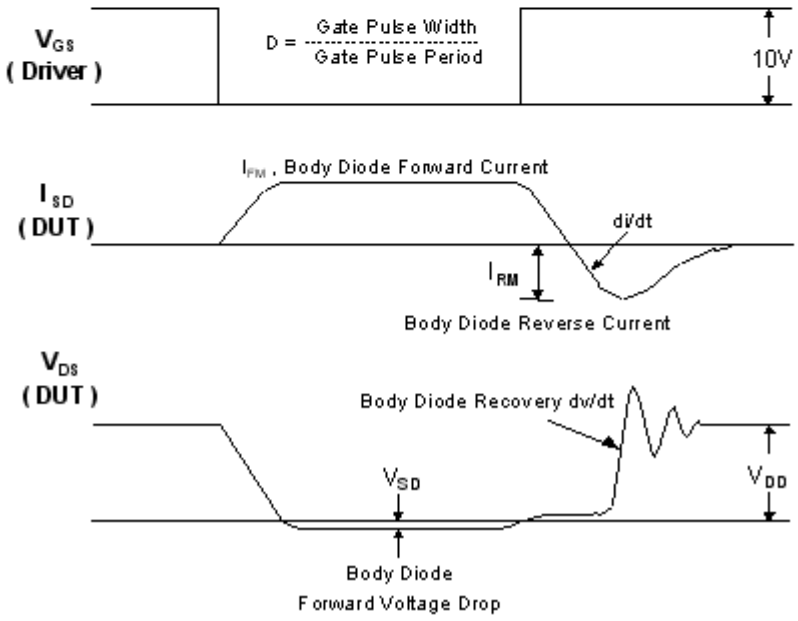


Unclamped Inductive Switching Test Circuit & Waveforms



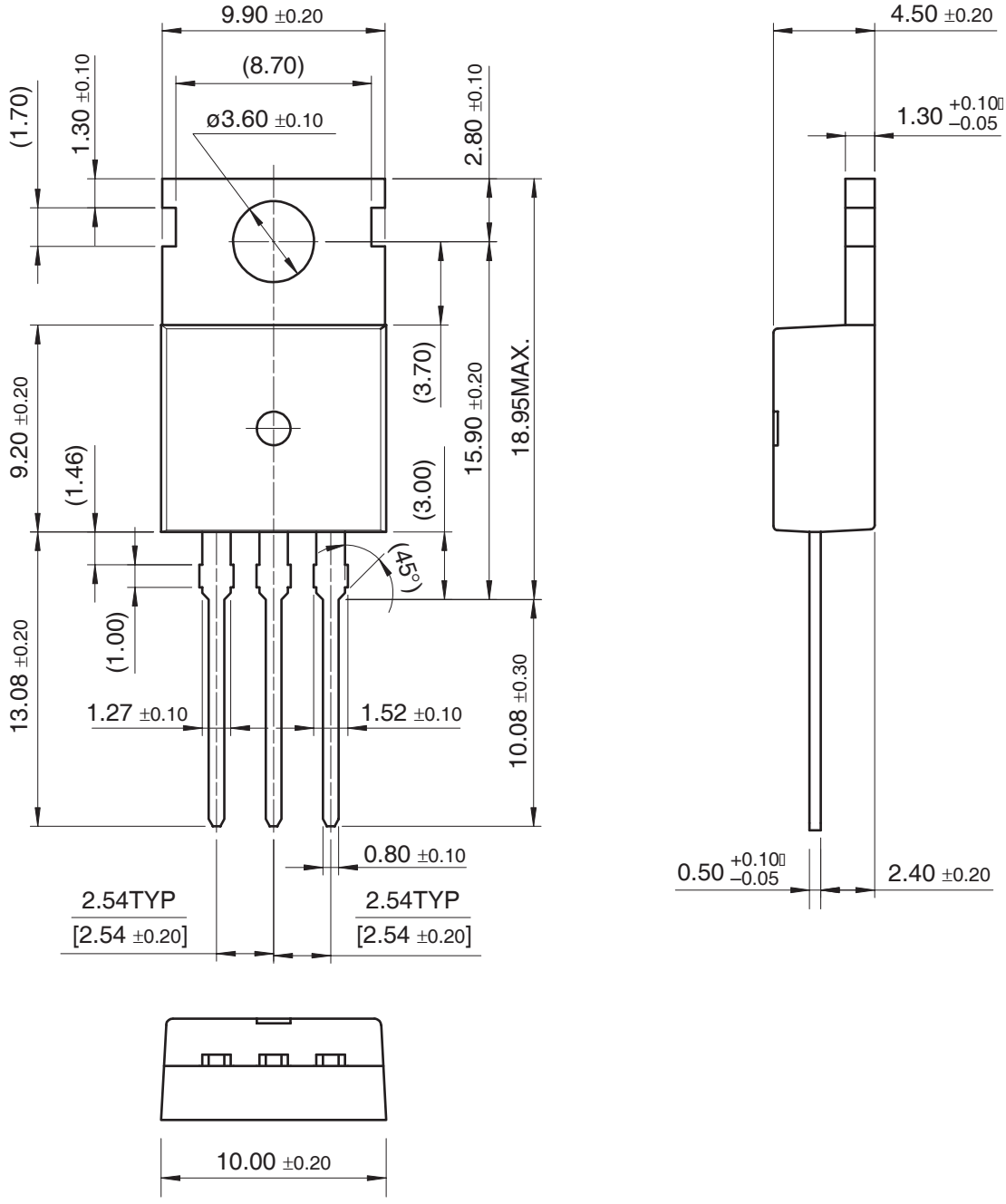
Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

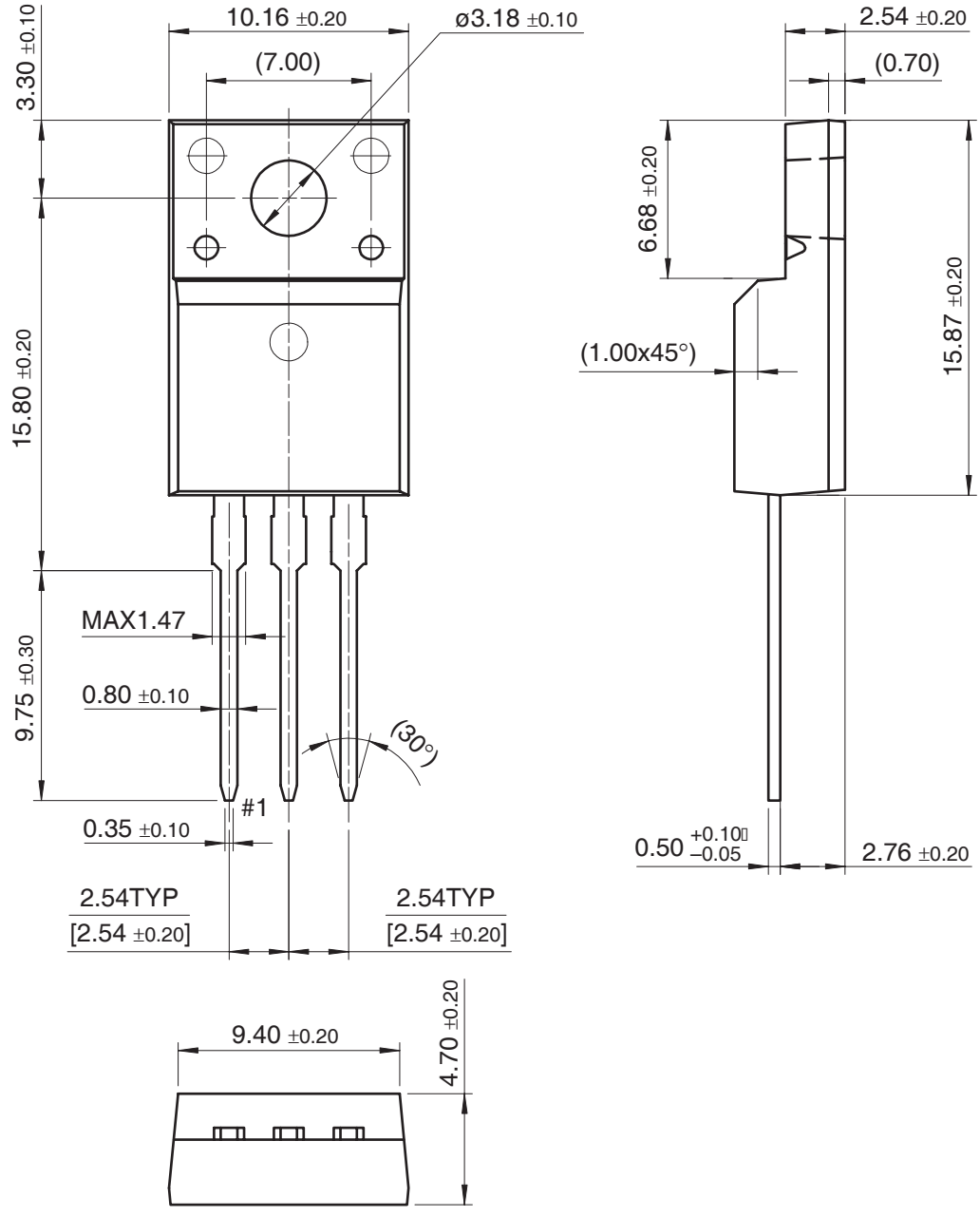
TO-220



Dimensions in Millimeters

Mechanical Dimensions (Continued)

TO-220F



Dimensions in Millimeters

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